

OptiMOS™3 Power-Transistor

Features

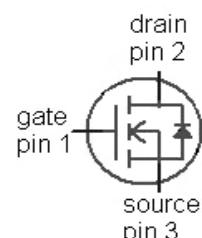
- Optimized technology for synchronous rectification
- Ideal for high frequency switching and DC/DC converters
- Excellent gate charge $\times R_{DS(on)}$ product (FOM)
- Very low on-resistance $R_{DS(on)}$
- N-channel, normal level
- 100% avalanche tested
- Pb-free plating; RoHS compliant, halogen free
- Qualified according to JEDEC¹⁾ for target applications

Product Summary

V_{DS}	75	V
$R_{DS(on),max}$	5.2	mΩ
I_D	80	A



Type	IPP052NE7N3 G	IPI052NE7N3 G
Package	PG-T0220-3	PG-T0262-3
Marking	052NE7N	052NE7N



Maximum ratings, at $T_j=25\text{ °C}$, unless otherwise specified

Parameter	Symbol	Conditions	Value	Unit
Continuous drain current	I_D	$T_c=25\text{ °C}$ ²⁾	80	A
		$T_c=100\text{ °C}$	80	
Pulsed drain current ²⁾	$I_{D,pulse}$	$T_c=25\text{ °C}$	320	
Avalanche energy, single pulse ³⁾	E_{AS}	$I_D=56\text{ A}$, $R_{GS}=25\text{ Ω}$	370	mJ
Gate source voltage	V_{GS}		± 20	V
Power dissipation	P_{tot}	$T_c=25\text{ °C}$	150	W
Operating and storage temperature	T_j , T_{stg}		-55 ... 175	°C
IEC climatic category; DIN IEC 68-1			55/175/56	

¹⁾J-STD20 and JESD22

²⁾ See figure 3 for more detailed information

³⁾ See figure 13 for more detailed information

Parameter	Symbol	Conditions	Values			Unit
			min.	typ.	max.	

Thermal characteristics

Thermal resistance, junction - case	R_{thJC}		-	-	1	K/W
Thermal resistance, junction - ambient	R_{thJA}	minimal footprint	-	-	62	
		6 cm ² cooling area ⁴⁾	-	-	40	

Electrical characteristics, at $T_j=25$ °C, unless otherwise specified

Static characteristics

Drain-source breakdown voltage	$V_{(BR)DSS}$	$V_{GS}=0$ V, $I_D=1$ mA	75	-	-	V
Gate threshold voltage	$V_{GS(th)}$	$V_{DS}=V_{GS}$, $I_D=91$ µA	2.3	3.1	3.8	
Zero gate voltage drain current	I_{DSS}	$V_{DS}=75$ V, $V_{GS}=0$ V, $T_j=25$ °C	-	0.1	1	µA
		$V_{DS}=75$ V, $V_{GS}=0$ V, $T_j=125$ °C	-	10	100	
Gate-source leakage current	I_{GSS}	$V_{GS}=20$ V, $V_{DS}=0$ V	-	1	100	nA
Drain-source on-state resistance	$R_{DS(on)}$	$V_{GS}=10$ V, $I_D=80$ A	-	4.7	5.2	mΩ
Gate resistance	R_G		-	2.2	-	Ω
Transconductance	g_{fs}	$ V_{DS} >2 I_D R_{DS(on)max}$, $I_D=80$ A	52	103	-	s

⁴⁾ Device on 40 mm x 40 mm x 1.5 mm epoxy PCB FR4 with 6 cm² (one layer, 70 µm thick) copper area for drain connection. PCB is vertical in still air.

Parameter	Symbol	Conditions	Values			Unit
			min.	typ.	max.	

Dynamic characteristics

Input capacitance	C_{iss}	$V_{GS}=0 \text{ V}, V_{DS}=37.5 \text{ V}, f=1 \text{ MHz}$	-	3570	4750	pF
Output capacitance	C_{oss}		-	805	1070	
Reverse transfer capacitance	C_{rss}		-	40	60	
Turn-on delay time	$t_{d(on)}$	$V_{DD}=37.5 \text{ V}, V_{GS}=10 \text{ V}, I_D=80 \text{ A}, R_G=1.6 \Omega$	-	14	-	ns
Rise time	t_r		-	11	-	
Turn-off delay time	$t_{d(off)}$		-	30	-	
Fall time	t_f		-	8	-	

Gate Charge Characteristics⁵⁾

Gate to source charge	Q_{gs}	$V_{DD}=37.5 \text{ V}, I_D=80 \text{ A}, V_{GS}=0 \text{ to } 10 \text{ V}$	-	20	-	nC
Gate to drain charge	Q_{gd}		-	11	-	
Switching charge	Q_{sw}		-	19	-	
Gate charge total	Q_g		-	51	68	
Gate plateau voltage	$V_{plateau}$		-	5.5	-	
Output charge	Q_{oss}		$V_{DD}=37.5 \text{ V}, V_{GS}=0 \text{ V}$	-	53	71

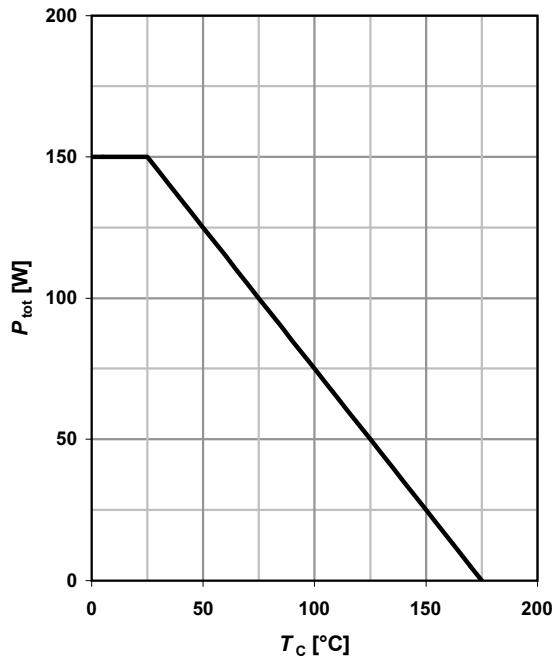
Reverse Diode

Diode continuous forward current	I_s	$T_c=25 \text{ }^\circ\text{C}$	-	-	80	A
Diode pulse current	$I_{s,pulse}$		-	-	320	
Diode forward voltage	V_{SD}	$V_{GS}=0 \text{ V}, I_F=80 \text{ A}, T_j=25 \text{ }^\circ\text{C}$	-	1.0	1.2	V
Reverse recovery time	t_{rr}	$V_R=37.5 \text{ V}, I_F=I_s, di_F/dt=100 \text{ A}/\mu\text{s}$	-	48	-	ns
Reverse recovery charge	Q_{rr}		-	87	-	nC

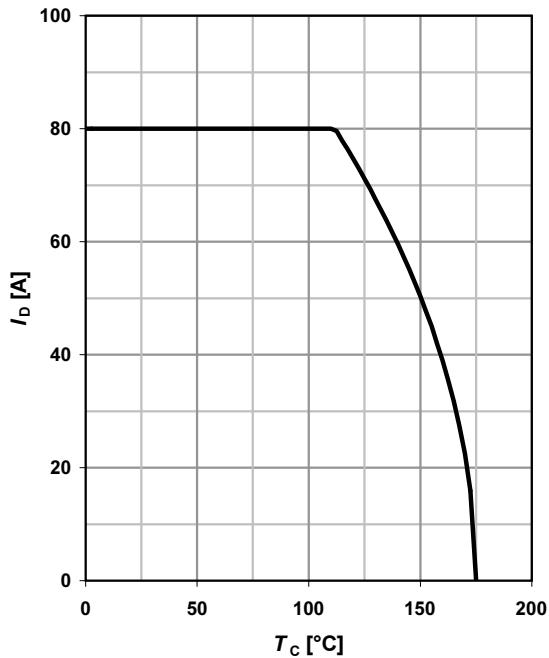
⁵⁾ See figure 16 for gate charge parameter definition

1 Power dissipation

$$P_{\text{tot}} = f(T_c)$$

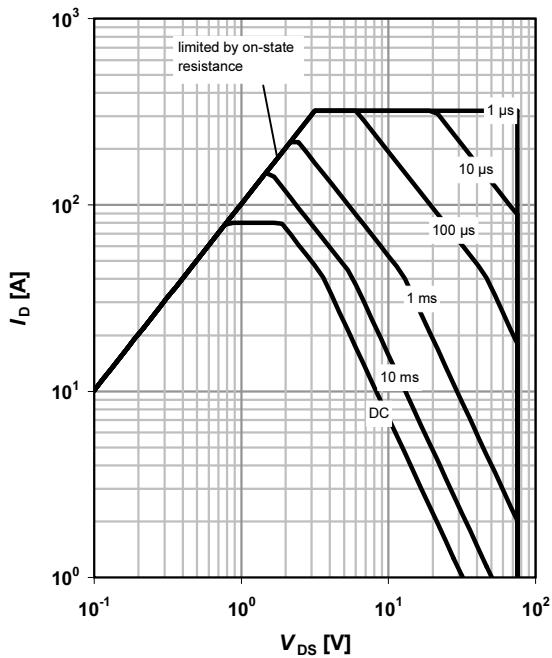

2 Drain current

$$I_D = f(T_c); V_{GS} \geq 10 \text{ V}$$


3 Safe operating area

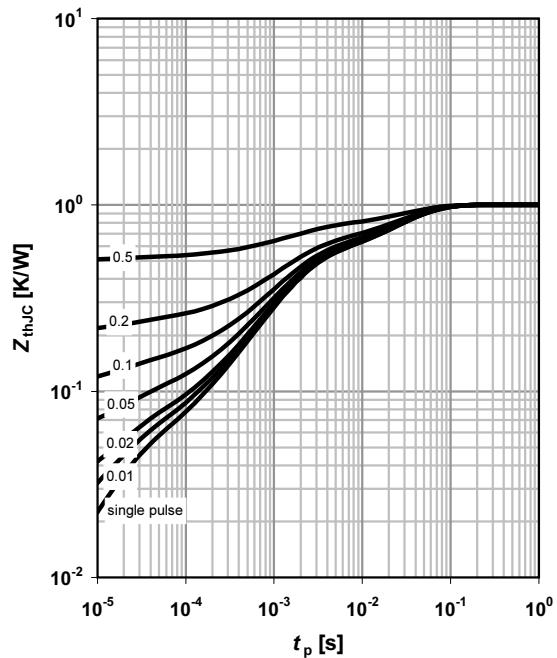
$$I_D = f(V_{DS}); T_c = 25 \text{ °C}; D = 0$$

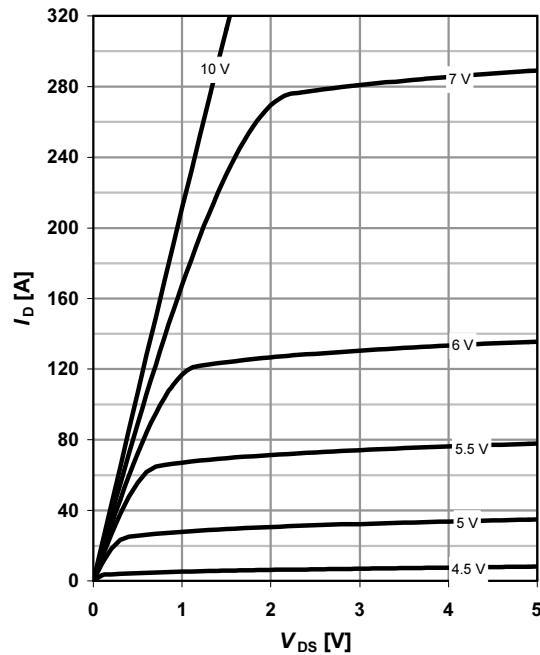
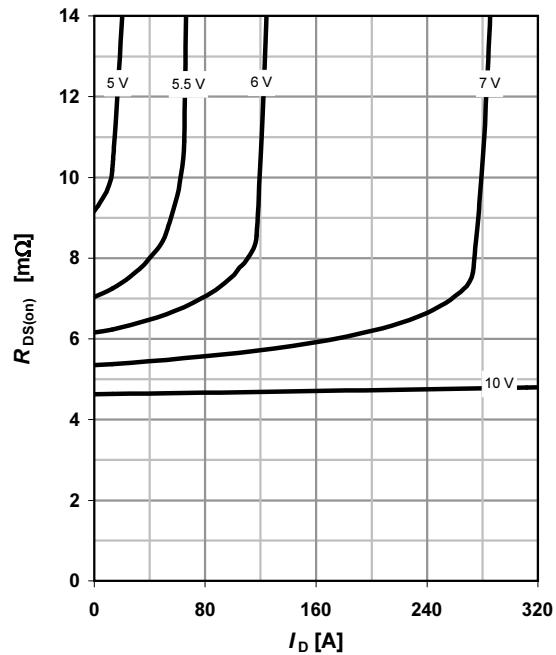
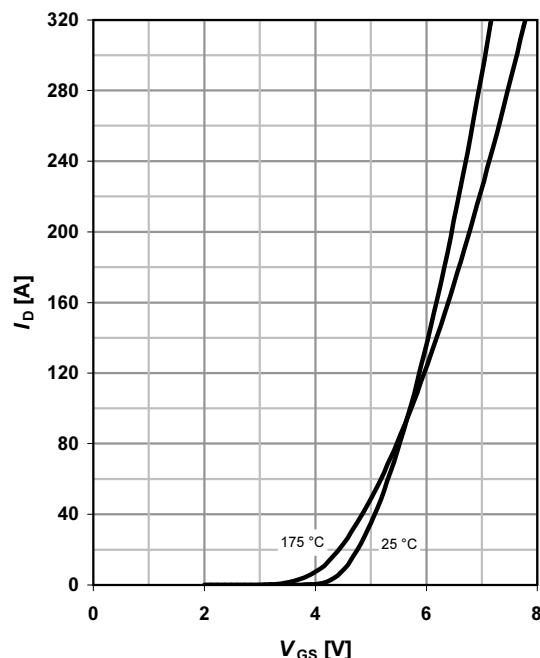
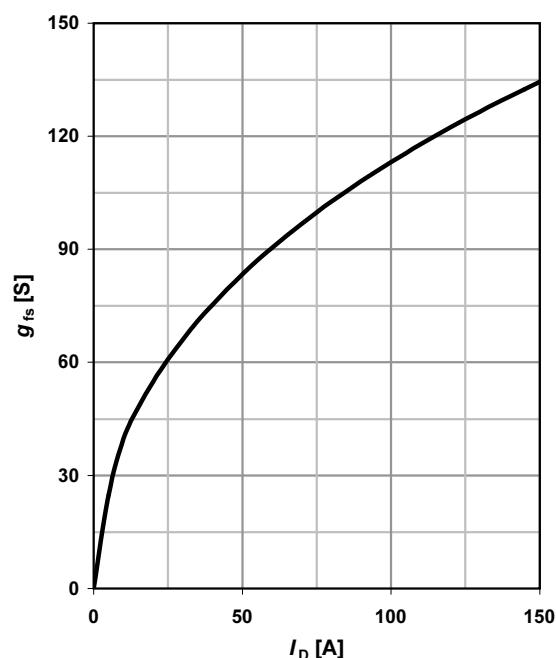
parameter: t_p

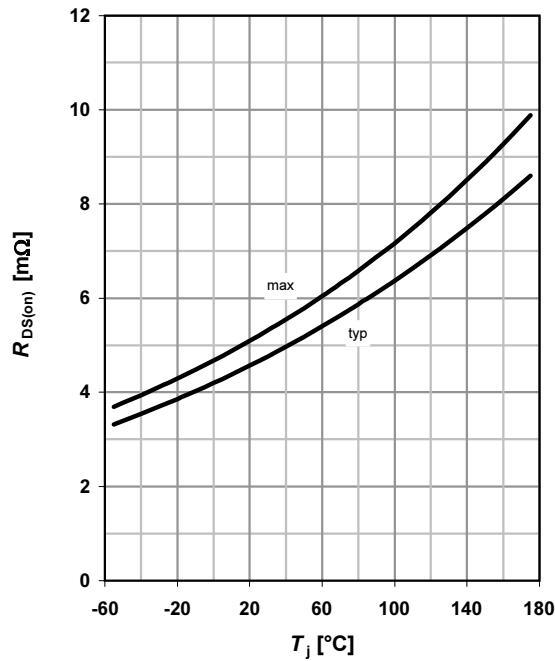

4 Max. transient thermal impedance

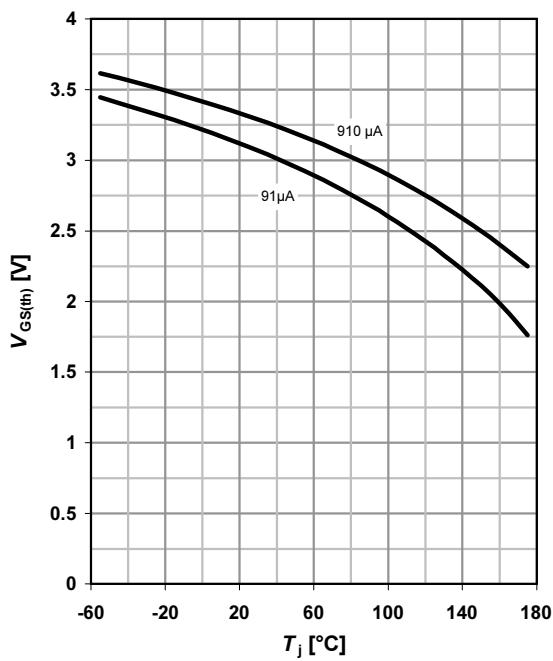
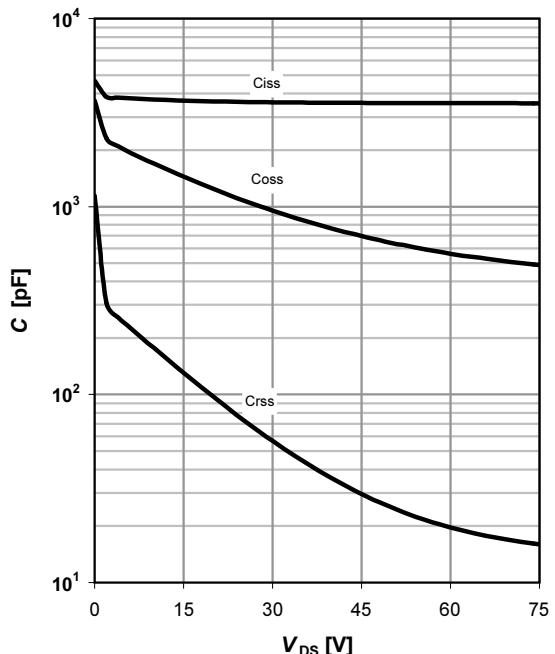
$$Z_{\text{thJC}} = f(t_p)$$

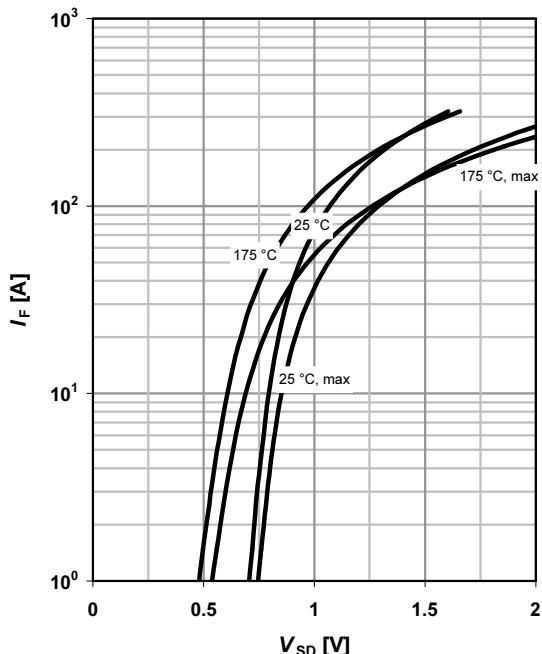
parameter: $D = t_p/T$



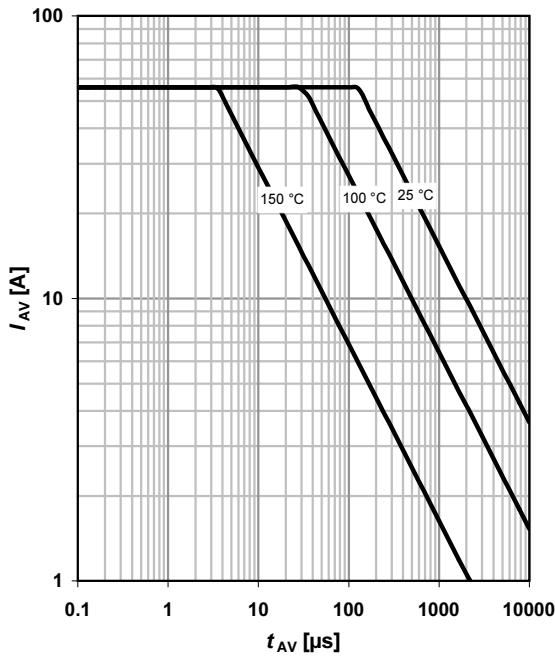
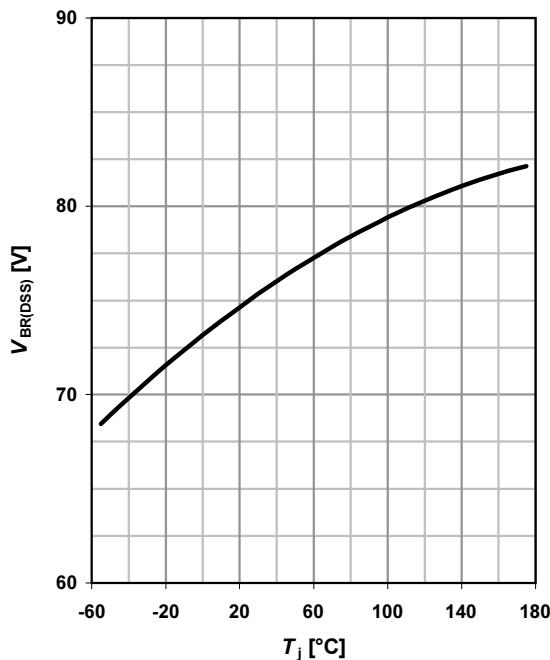
5 Typ. output characteristics
 $I_D = f(V_{DS})$; $T_j = 25^\circ\text{C}$
parameter: V_{GS} 
6 Typ. drain-source on resistance
 $R_{DS(on)} = f(I_D)$; $T_j = 25^\circ\text{C}$
parameter: V_{GS} 
7 Typ. transfer characteristics
 $I_D = f(V_{GS})$; $|V_{DS}| > 2|I_D|R_{DS(on)max}$
parameter: T_j 
8 Typ. forward transconductance
 $g_{fs} = f(I_D)$; $T_j = 25^\circ\text{C}$


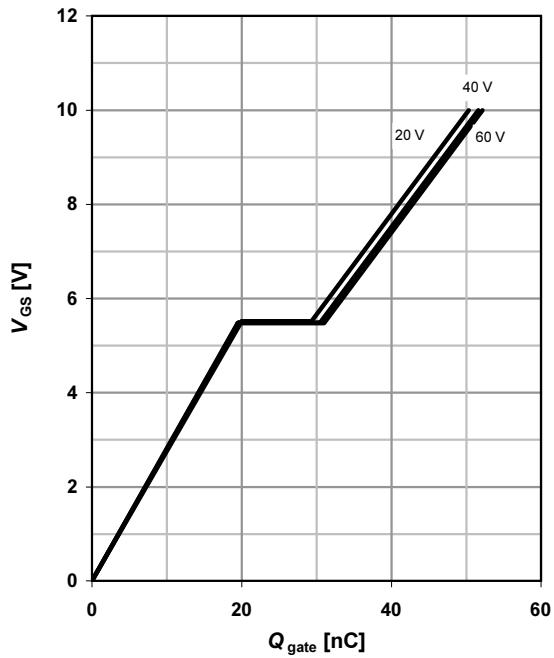
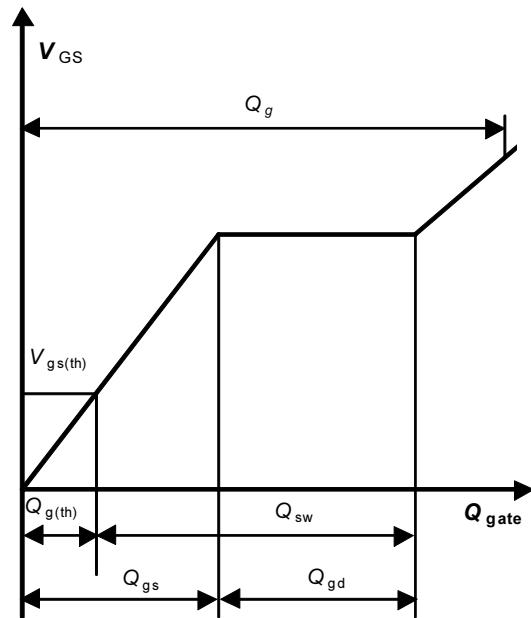
9 Drain-source on-state resistance
 $R_{DS(on)} = f(T_j); I_D = 80 \text{ A}; V_{GS} = 10 \text{ V}$

10 Typ. gate threshold voltage
 $V_{GS(th)} = f(T_j); V_{GS} = V_{DS}$

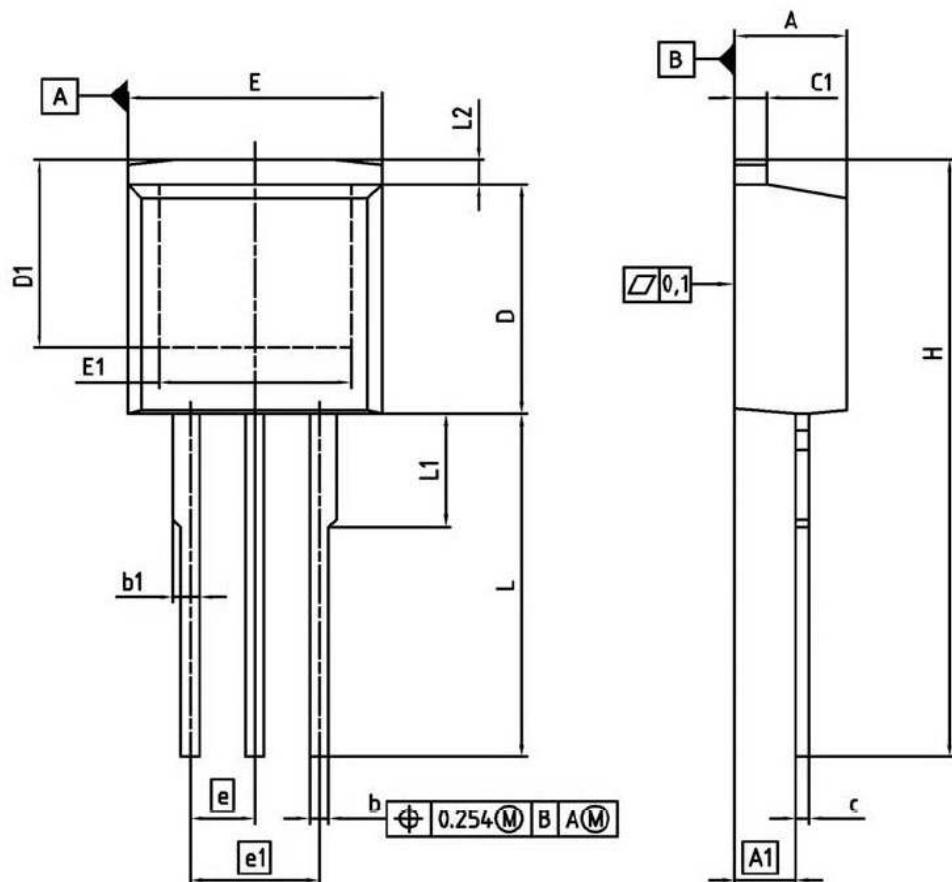
 parameter: I_D

11 Typ. capacitances
 $C = f(V_{DS}); V_{GS} = 0 \text{ V}; f = 1 \text{ MHz}$

12 Forward characteristics of reverse diode
 $I_F = f(V_{SD})$

 parameter: T_j


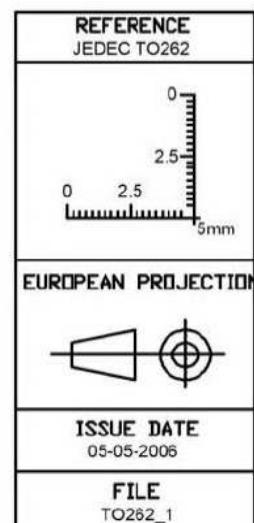
13 Avalanche characteristics
 $I_{AV} = f(t_{AV})$; $R_{GS} = 25 \Omega$

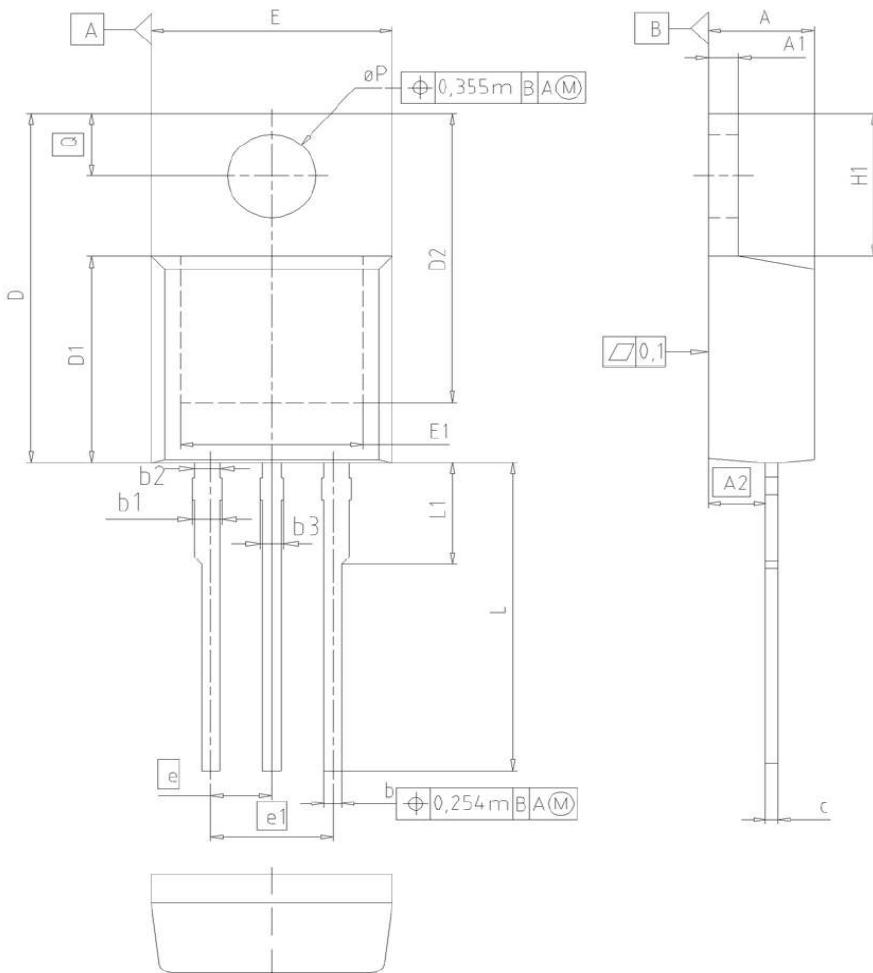
parameter: $T_{j(start)}$

15 Drain-source breakdown voltage
 $V_{BR(DSS)} = f(T_j)$; $I_D = 1 \text{ mA}$

14 Typ. gate charge
 $V_{GS} = f(Q_{gate})$; $I_D = 80 \text{ A pulsed}$

parameter: V_{DD}

16 Gate charge waveforms


PG-T0262-3 (I²-Pak)


DIM	MILLIMETERS		INCHES	
	MIN	MAX	MIN	MAX
A	4.300	4.572	0.169	0.180
A1	2.150	2.718	0.085	0.107
b	0.650	0.864	0.026	0.034
b1	0.635	1.400	0.025	0.055
c	0.330	0.600	0.013	0.024
c1	1.170	1.400	0.046	0.055
D	8.509	9.450	0.335	0.372
D1	6.900	-	0.272	-
E	9.700	10.363	0.382	0.408
E1	6.500	8.600	0.256	0.339
e	2.540		0.100	
e1	5.080		0.200	
N	3		3	
L	13.000	14.000	0.512	0.551
L1	-	4.800	-	0.189
L2	-	1.727	-	0.068



PG-T0220-3


DIM	MILLIMETERS		INCHES	
	MIN	MAX	MIN	MAX
A	4.30	4.57	0.169	0.180
A1	1.17	1.40	0.046	0.055
A2	2.15	2.72	0.085	0.107
b	0.65	0.86	0.026	0.034
b1	0.95	1.40	0.037	0.055
b2	0.95	1.15	0.037	0.045
b3	0.65	1.15	0.026	0.045
c	0.33	0.60	0.013	0.024
D	14.81	15.95	0.583	0.628
D1	8.51	9.45	0.335	0.372
D2	12.19	13.10	0.480	0.516
E	9.70	10.36	0.382	0.408
E1	6.50	8.60	0.256	0.339
e	2.54		0.100	
e1	5.08		0.200	
N	3		3	
H1	5.90	6.90	0.232	0.272
L	13.00	14.00	0.512	0.551
L1	-	4.80	-	0.189
ϕP	3.60	3.89	0.142	0.153
Q	2.60	3.00	0.102	0.118

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